

CUSTOMER: _____

DATE: _____

For Automotive Electronics

APPROVAL SPECIFICATION

ROHS+HS
COMPLIANT

车载品
AEC-Q200

PRODUCT NAME: SMD Wire Wound Chip Inductor

YOUR PART NO.:

OUR PART NO.: AMTF0603HW Series

VERSION: V1.0

| | | |
|---|------|-------|
| RECEPTION THE SPECIFICATION HAS BEEN ACCEPTED. | | |
| COMPANY: | | DATE: |
| CFMD | CHKD | RCVD |

MANUFACTURING NAME

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| | | |
|-------|-------|---------|
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CATALOG

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Component SPEC Version Record

| Rev. | Effective Date | Changed Contents | Change Reasons | Approved By |
|------|----------------|------------------|----------------|-------------|
| 1.0 | 2019.09.25 | New released | / | Remo |
| | | | | |

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1. Scope

This specification applies to the AMTF0603HW series of SMD Wire Wound Chip Inductors.

2. Product Identification

AMTF 0603 HW R33 K S T
 ① ② ③ ④ ⑤ ⑥ ⑦

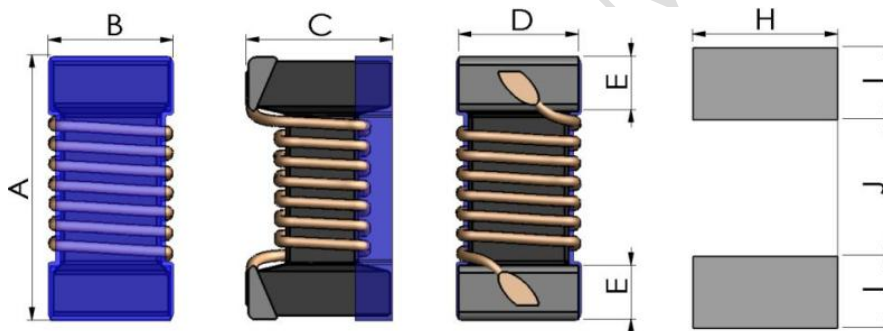
- ① Product Symbol
- ② Dimensions (0603 inch)
- ③ Features
- ④ Inductance Value (1N6:1.6nH 27N:27nH; R33:330nH; 1R0:1.0uH)
- ⑤ Inductance Tolerance

| Code | G | H | J | K | M |
|-----------|-----|-----|-----|------|------|
| Tolerance | ±2% | ±3% | ±5% | ±10% | ±20% |

- ⑥ Termination materials (G: gold ; S: sn)
- ⑦ Packaging style (T: Taping ; B: Bulk)

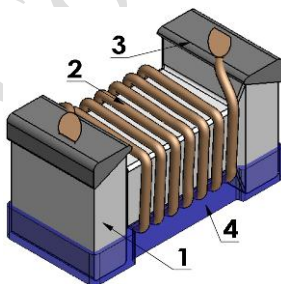
3. Appearance, Dimensions and Material

(1) Appearance and dimensions



| Dimensions in mm | | | | | | | |
|------------------|---------|----------|-----------|-----------|-----------|-----------|-----------|
| A | B | C | D | E | H | I | J |
| 1.6±0.2 | 1.0±0.1 | 1.0 Max. | 0.90 Ref. | 0.30 Typ. | 1.02 Typ. | 0.64 Typ. | 0.64 Typ. |

(2) Material List



| No. | Item | Material |
|-----|--------------------|-------------------------|
| 1 | Core | Ferrite |
| 2 | Wire | Enameled Copper Wire |
| 3 | Terminal Electrode | Sn |
| 4 | Coating | Ultraviolet epoxy resin |

4. Testing Conditions

Unless otherwise specified, the standard conditions for measurement/test as:

Ambient Temperature : 5 to 35°C
Relative Humidity: 25 to 85% RH
Atmospheric Pressure: 86 to 106 kPa

If any doubt on the results, measurements/tests should be made within the following limits:

Ambient Temperature : 25±1°C
Relative Humidity: 60 to 70% RH
Atmospheric Pressure: 86 to 106 kPa

5. Rating

Operating temperature:-55°C~150°C

| Microgate Part No. | L (uH) | Tolerance | Q (typ.) | L/Q Test Frequency (MHz) | DCR (Ω) | I _{rms} (mA) | I _{sat} (mA) | SRF (MHz) (min.) |
|--------------------|--------|-----------|----------|--------------------------|----------|-----------------------|-----------------------|------------------|
| AMTF0603HW1R0KST | 1.0 | ±10% | 16 | 7.9/7.9 | 0.32±30% | 700 | 860 | 400 |
| AMTF0603HW2R2KST | 2.2 | ±10% | 16 | 7.9/7.9 | 0.56±30% | 580 | 600 | 85 |
| AMTF0603HW3R3KST | 3.3 | ±10% | 16 | 7.9/7.9 | 0.80±30% | 580 | 580 | 60 |
| AMTF0603HW4R7KST | 4.7 | ±10% | 16 | 7.9/7.9 | 0.97±30% | 500 | 550 | 51 |
| AMTF0603HW6R8KST | 6.8 | ±10% | 16 | 7.9/7.9 | 1.5±30% | 280 | 320 | 43 |
| AMTF0603HW100KST | 10 | ±10% | 14 | 2.5/7.9 | 1.50±30% | 280 | 300 | 36 |
| AMTF0603HW150KST | 15 | ±10% | 14 | 2.5/2.5 | 2.60±30% | 240 | 280 | 25 |
| AMTF0603HW220KST | 22 | ±10% | 14 | 2.5/2.5 | 3.61±30% | 200 | 250 | 24 |

6. Electrical Performance

Inductance;

Inductance shall meet item 5 when measured on the condition of Table 1.

Table 1

| | |
|------------------------|--|
| Measuring Equipment | Impedance analyzer keysight E4982A or equivalent |
| Measuring Frequency | In the table |
| Measuring signal level | -13dBm |
| Measuring Fixture | keysight 16197A |

DC Resistance

D.C Resistance shall meet item 5 when measured on the condition of Table 2.

Table 2

| | |
|---------------------|------------------------------------|
| Measuring Equipment | LCR Meter HIOKI 3542 or equivalent |
|---------------------|------------------------------------|

Self-Resonant Frequency (S.R.F)

S.R.F. shall meet item 5 when measured on the condition of Table 3.

Table 3

| | |
|---------------------|---|
| Measuring Equipment | Impedance analyzer Agilent E4991A, Network analyzer Keysight E5071C or equivalent |
|---------------------|---|

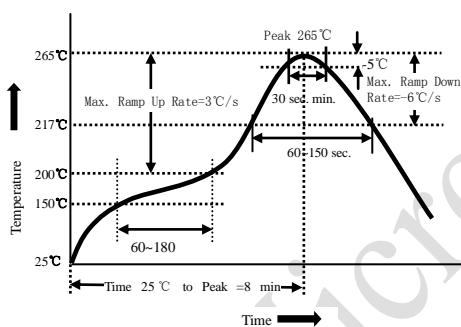
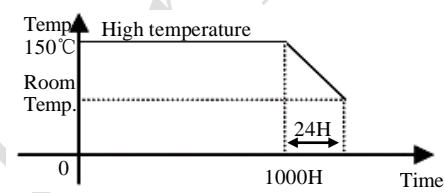
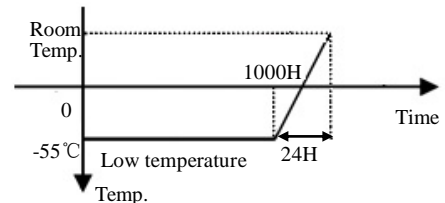
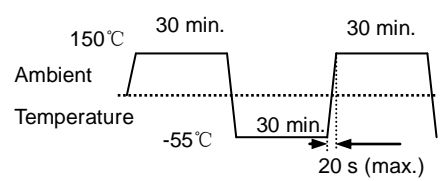
Rated current

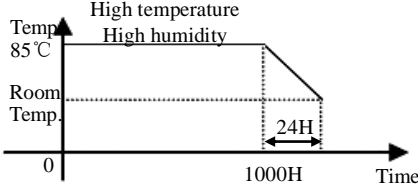
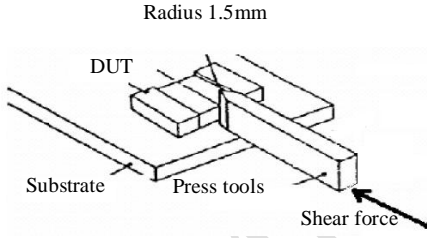
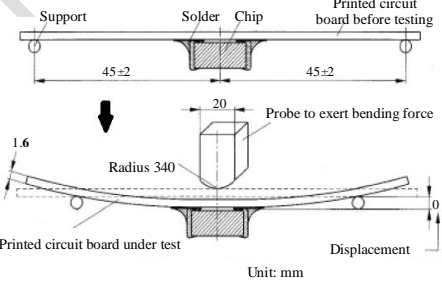
Temperature rise no more than 40°C against chip surface temperature when the allowable current (which is mentioned in item 5) is applied.

Table 4

| | |
|---------------------|---|
| Measuring Equipment | DC Power Supplier, Current Meter, Thermometer |
|---------------------|---|

7. Reliability

| No. | Item | Requirements | Test Methods and Remarks | Reference | Sample Size |
|-----|------------------------------|---|--|-----------|-------------|
| 1 | Solderability | Terminal area shall be at least 95% covered . | ①Temperature: $245 \pm 5^{\circ}\text{C}$, flux 5-10 s. ②Sample immersion tin furnace $3 \pm 1\text{s}$. ③Sn/3.0Ag/0.5Cu | AEC-Q200 | 15 |
| 2 | Resistance to Soldering Heat | | ①The peak temperature: $260+5/-0^{\circ}\text{C}$. ②Reflow: 3times. ③Temperature curve is as below:  | AEC-Q200 | 30 |
| 3 | High Temperature Storage | (1) No case deformation or change in appearance. (2) $ \Delta L/L_0 \leq 5\%$ (3) $ \Delta Q/Q_0 \leq 20\%$ (4) $ \Delta \text{DCR}/\text{DCR}_0 \leq 10\%$ | ①Temperature: $150 \pm 2^{\circ}\text{C}$. ②Time : 1000(+48,0) hours. ③Measurement at 24 ± 4 hours after test conclusion.  | AEC-Q200 | 77 |
| 4 | Low Temperature Storage | | ①Temperature: $-55 \pm 2^{\circ}\text{C}$. ②Time : 1000(+48,0) hours. ③Measurement at 24 ± 4 hours after test conclusion.  | AEC-Q200 | 77 |
| 5 | Thermal shock | | ①First -55°C for 30 minutes, last 150°C 30minutes as 1 cycle. Go through 1000 cycles. ②Max transfer time is 20 second. ③Measurement at 24 ± 4 hours after test conclusion.  | AEC-Q200 | 30 |

| | | | | | |
|----|---------------------|---|--|----------|----|
| 6 | Humidity Resistance | <p>(1) No case deformation or change in appearance. (2) $\Delta L/L_0 \leq 5\%$ (3) $\Delta Q/Q_0 \leq 20\%$ (4) $\Delta DCR/DCR_0 \leq 10\%$</p> | <p>①1000(+48,0) hours, 85 °C/85% RH. ②Unpowered. ③Measurement at 24±4 hours after test conclusion.</p>  | AEC-Q200 | 77 |
| 7 | Terminal Strength | No case deformation or change in appearance. | <p>①The test samples shall be soldered to the board. ②A Force of 5.0N, 5s</p>  | AEC-Q200 | 30 |
| 8 | Board Flex | <p>(1) No case deformation or change in appearance. (2) $\Delta L/L_0 \leq 5\%$ (3) $\Delta Q/Q_0 \leq 20\%$ (4) $\Delta DCR/DCR_0 \leq 10\%$</p> | <p>①Part mounted on a 100mm*40mm FR4 PCB board, which is 0.8mm thick and as a Layer-thickness 35 μm ± 10 μm. ②Bending speed is 1mm/s. ③Keeping the P.C Board 2 mm minimum for 60 seconds.</p>  | AEC-Q200 | 30 |
| 9 | Drop | <p>(1) No case deformation or change in appearance.</p> | <p>①Height: 1 m, Free fall, 10times. ②Direction: 1 Angle, 1side, 2surface.</p> | AEC-Q200 | 30 |
| 10 | Vibration | <p>(2) $\Delta L/L_0 \leq 5\%$ (3) $\Delta Q/Q_0 \leq 20\%$ (4) $\Delta DCR/DCR_0 \leq 10\%$</p> | <p>10~2000Hz,5g,20min/Cycle,4 hours in each 3 mutually perpendicular directions (total of 12 hours)</p> | AEC-Q200 | 30 |

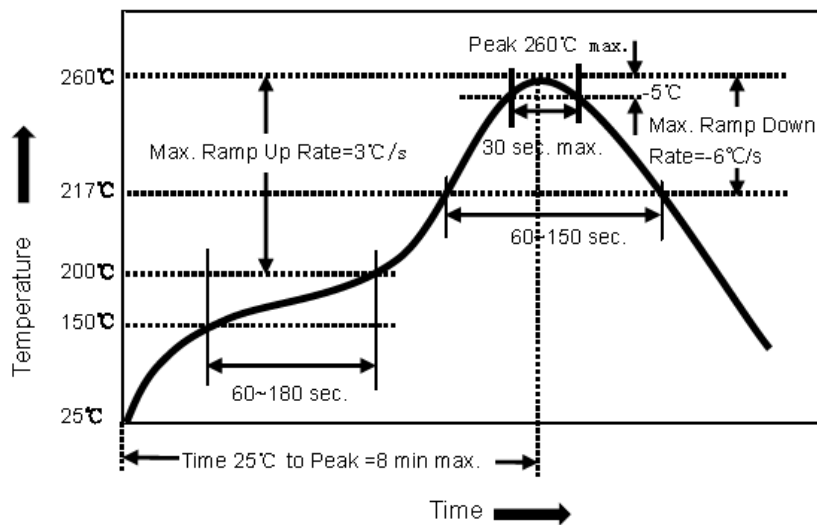
| No. | Item | Requirements | Test Methods and Remarks | Reference | Sample Size |
|-----|-------------------------------|---|---|-------------|-------------|
| 11 | Mechanical Shock | (1) No case deformation or change in appearance. (2) $ \Delta L/L_0 \leq 5\%$ (3) $ \Delta Q/Q_0 \leq 20\%$ (4) $ \Delta DCR/DCR_0 \leq 10\%$ | Half sine shock pulse, 100g, 6ms, 6 shocks in each 3 mutually perpendicular directions (total of 18 shocks) | AEC-Q200 | 30 |
| 12 | Loading at High Temperature | (1) No case deformation or change in appearance. (2) $ \Delta L/L_0 \leq 5\%$ (3) $ \Delta Q/Q_0 \leq 20\%$ (4) $ \Delta DCR/DCR_0 \leq 10\%$ | ①Temperature: $150 \pm 2^\circ\text{C}$. ②Time : 1000(+48,0) hours. ③Rated current. ④Measurement at 24 ± 4 hours after test conclusion. | AEC-Q200 | 77 |
| 13 | Loading at Damp Heat | (1) No case deformation or change in appearance. (2) $ \Delta L/L_0 \leq 5\%$ (3) $ \Delta Q/Q_0 \leq 20\%$ (4) $ \Delta DCR/DCR_0 \leq 10\%$ | ①Temperature: $60 \pm 2^\circ\text{C}$, Humidity: 90% to 95% RH ; ② Duration: 1000(+48,0) hours ③ current: Rated current. ④Measurement at 24 ± 4 hours after test conclusion. | AEC-Q200 | 77 |
| 14 | ESD Test | (1) No case deformation or change in appearance. (2) $ \Delta L/L_0 \leq 5\%$ (3) $ \Delta Q/Q_0 \leq 20\%$ (4) $ \Delta DCR/DCR_0 \leq 10\%$ | HBM ESD discharge waveform, 8KV | AEC-Q200 | 15 |
| 15 | Moisture Resistance | (1) No case deformation or change in appearance. (2) $ \Delta L/L_0 \leq 5\%$ (3) $ \Delta Q/Q_0 \leq 20\%$ (4) $ \Delta DCR/DCR_0 \leq 10\%$ | Method106 | MIL-STD-202 | 77 |
| 16 | Flammability (External Flame) | (1) No case deformation or change in appearance. (2) $ \Delta L/L_0 \leq 5\%$ (3) $ \Delta Q/Q_0 \leq 20\%$ (4) $ \Delta DCR/DCR_0 \leq 10\%$ | Method111/UL94 | MIL-STD-202 | 15 |
| 17 | Resistance to Solvents | (1) No case deformation or change in appearance. (2) $ \Delta L/L_0 \leq 5\%$ (3) $ \Delta Q/Q_0 \leq 20\%$ (4) $ \Delta DCR/DCR_0 \leq 10\%$ | Method215 | MIL-STD-202 | 77 |

*All above experiments items need 3 Lot., sample size is as specified in the table above.

*Sample size standard is from AEC-Q200: qualification sample size requirements.

8. Recommended Soldering Conditions

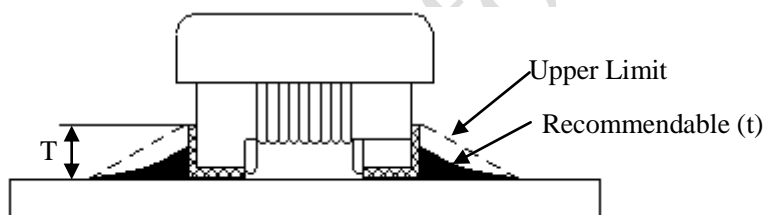
(1) Reflow soldering conditions



Above reflow soldering curve is from J-STD-020D.

(2) Solder Volume

Solder shall be used not to be exceeded the upper limits as shown below.



$$1/3T \leq t \leq T$$

(T: Height of electrode)

- Exceeding solder volume may cause the failure of mechanical or electrical performance.
- Before soldering, please ensure that the solder should not adhere to the wire part of chip.
- Please pay particular attention to whether there is flux remaining on surface of the wire part of chip after subjected to reflow soldering since this may causing short circuit of parts.

(3) Iron soldering

The following conditions must be strictly followed when using a soldering iron.

①

| | |
|-----------------------|-----------------|
| Pre-heating | 150°C, 1 minute |
| Tip temperature | 350°C max |
| Soldering iron output | 30w max |
| End of soldering iron | φ 1mm max |
| Soldering time | 3 seconds max |

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- ②Don't touch the coil core directly with the top of the iron
- ③In the welding process, the electric iron cannot bump into the enamel-insulated wire, lest components should have evidence of damage.
- ④The test, link products and so on solder correct and support on both sides the method contrast wrongly:

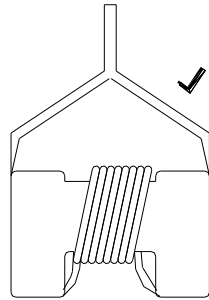


Figure 1 Correct method

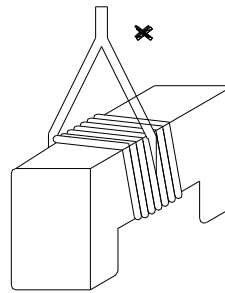


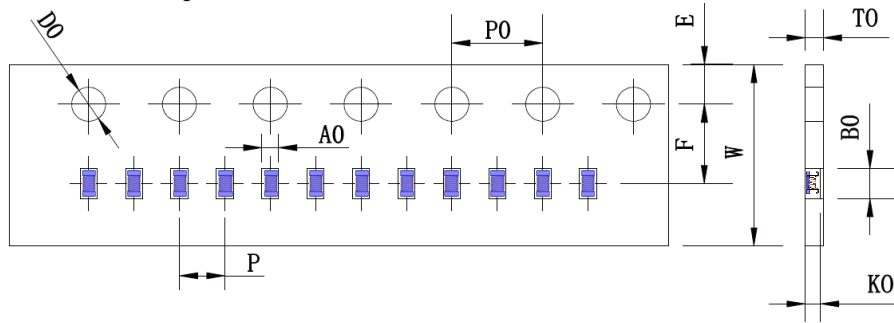
Figure 2 Wrongly method

Tweezers of fixture should support on both sides of the chip, and the correct support way as shown as Figure1. Tweezers of fixture should not support on enamel-insulated wire of the chip, lest enamel-insulated wire should have evidence of damage, the wrong support way as shown as Figure 2.

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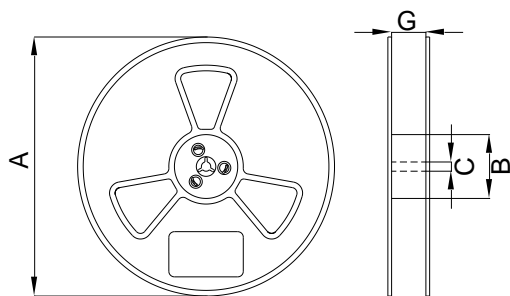
9. Packaging Information

(1) Dimension of tape (Unit: mm)



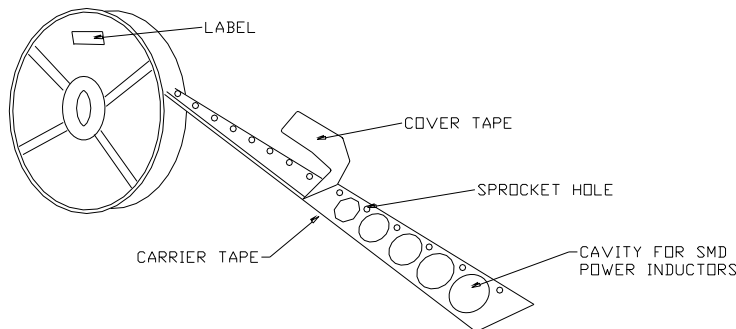
| W | E | F | P | P0 | D0 | T0 |
|---------|-----------|----------|----------|---------|--------------|-----------|
| 8.0±0.2 | 1.75±0.05 | 3.5±0.05 | 4.0±0.05 | 4.0±0.1 | 1.5+0.1/-0.0 | 1.10 max. |

(2) Dimension of reel (Unit: mm)



| Symbol | Dimension |
|--------|-----------|
| A | 178±2 |
| B | 58±2 |
| C | 13.5±0.2 |
| G | 10.0±1.5 |

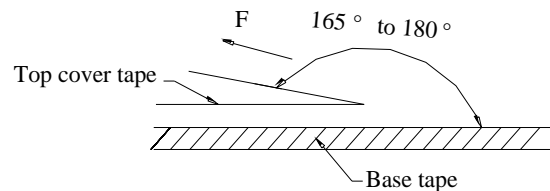
(3) Taping figure and drawing direction



(4) Packaging quantities: 3,000PCS/Reel.

(5) Peeling strength of cover tape:

The force tearing off cover tape is 15 to 65 grams in the arrow direction under the following conditions.



| Room Temp. (°C) | Room Humidity (%) | Room aim (hpa) | Peel Speed mm/min |
|-----------------|-------------------|----------------|-------------------|
| 5-35 | 45-85 | 860-1060 | 300 |

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10. Storage

- a. The solder ability of the external electrode may be deteriorated if packages are stored where they are exposed to high temperature or high humidity. Besides, to ensure packing material's good state, packages must be stored at -10°C to 40°C and 15% ~85% RH.
- b. The solder ability of the external electrode may be deteriorated if packages are stored where they are exposed to dust of harmful gas (e.g. HCl, sulfurous gas of H₂S).
- c. Packaging materials may deform if packages are exposed directly to sunlight.
- d. Minimum packages, such as polyvinyl heat-seal packages shall not be opened until they are used. If opened, use the reels as soon as possible.
- e. Solderability shall be guaranteed for 12 months from the date of manufacture on condition that they are stored at the environment specified in specification. For those parts, which passed more than the time shall be checked solder-ability before use.

11. Transportation

The cases shall not be damaged, destroyed and rained on.

12. Warning and Attentions

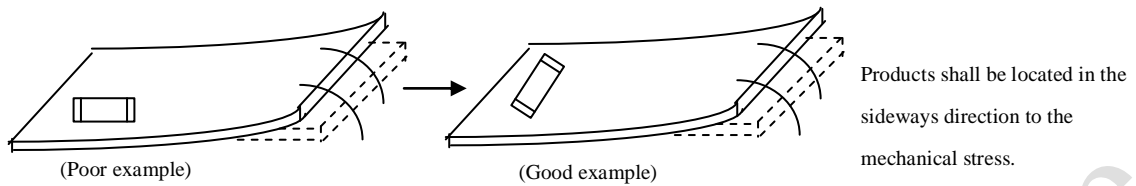
(1) Precautions on Use

- a. Always wear static control bands to protect against ESD.
- b. Any devices used (soldering iron, measuring instruments) should be properly grounded.
- c. Use non-magnetic tweezers when handing the chips.
- d. Pre-heating when soldering, and refer to the recommended condition specified in specification.
- e. Don't apply current in excess of the rated current value. It may cause damage to components due to over-current.
- f. Keep clear of anything that may generate magnetic fields such as speakers, coils.
- g. When soldering, the electrical characteristics may be varied due to hot energy and mechanical stress.
- h. When coating products with resin, the relatively high resin curing stress may change the electrical characteristics. For exterior coating, select resin carefully so that electrical and mechanical performance of the product is not affected. Before using, please evaluate reliability with the product mounted in your application set.
- i. When mount chips with adhesive in preliminary assembly, do appropriate check before the soldering stage, i.e., the size of land pattern, type of adhesive, amount applied, hardening of the adhesive on proper usage and amounts of adhesive to use.
- j. Mounting density: Add special attention to radiating heat of products when mounting other components nearby. The excessive heat by other products may cause deterioration at joint of this product with substrate.
- k. Since some products are constructed like an open magnetic circuit, narrow spacing between components may cause magnetic coupling.
- l. Please do not give the product any excessive mechanical shocks in transportation.
- m. Please do not touch wires by sharp terminals such as tweezers to avoid causing any damage to wires.
- n. Please do not add any shock and power to the soldered product to avoid causing any damage to chip body.
- o. Please do not touch the electrodes by naked hand as the solderability of the external electrodes may deteriorate by grease or oil on the skin.

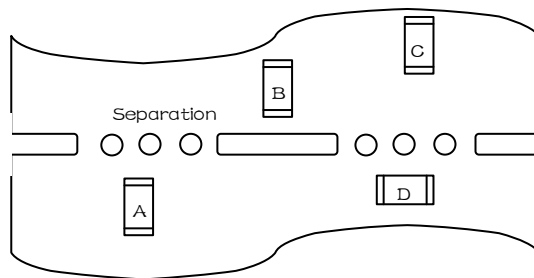
(2) PCB Bending Design

The following shall be considered when designing and laying out PCB's.

1. PCB shall be designed so that products are not subjected to the mechanical stress from board warp or deflection.



2. Products location on PCB separation.



Product shall be located carefully because they may be subjected to the mechanical stress in order of $A > C = B > D$.

3. When splitting the PCB board, or insert (remove) connector, or fasten thread after mounting components, care is required so as not to give any stress of deflection or twisting to the board. Because mechanical force may cause deterioration of the bonding strength of electrode and solder, even crack of product body. Board separation should not be done manually, but by using appropriate devices.

(3) Recommended PCB Design for SMT Land-Patterns

When chips are mounted on a PCB, the amount of solder used (size of fillet) and the size of PCB Land-Patterns can directly affect chip performance. Therefore, the following items must be carefully considered in the design of solder land patterns.

- a. Please use the PCB pad and solder paste we recommend, and contact us in advance if they need to be changed.
- b. The amount of solder applied can affect the ability of chips to withstand mechanical stresses which may lead to breaking or cracking. Therefore, when designing land-patterns it is necessary to consider the appropriate size and configuration of the solder pads which in turn determines the amount of solder necessary to form the fillets.
- c. When more than one part is jointly soldered onto the same land or pad, the pad must be designed that each component's soldering point is separated by solder-resist.

Recommended land dimensions please refer to product specification.

13. Cleaning

Products shall be cleaned on the following conditions:

- (1) Cleaning temperature shall be limited to 60°C Max. (40°C Max. for IPA)
- (2) Ultrasonic cleaning shall comply with the following conditions, avoiding the resonance phenomenon at the mounted products and PCB.

Power: 20W/1 Max. Frequency: 28 KHz to 40 KHz Time: 5 minutes Max

(3) Cleaner

a. Alcohol type cleaner

Isopropyl alcohol (IPA)

b. Aqueous agent

Surface Active Agent Type (Clean through-750H)

Hydrocarbon Type (Techno Cleaner-335)

Higher Alcohol Type (Pine Alpha ST-100S)

c. There shall be no residual flux and residual cleaner after cleaning.

In the case of using aqueous agent, product shall be dried completely after rinse with de-ionized water in order to remove the cleaner.

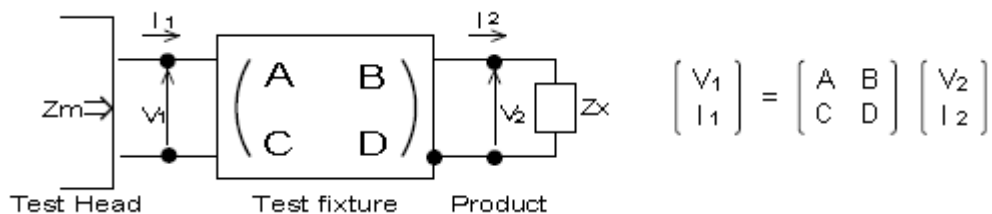
d. Some products may become slightly whitened. However, product performance or usage is not affected.

e. Please take care of winding part while cleaning.

f. After cleaning, parts could be subjected to the next reflow soldering till the solvent remaining on surface of parts being volatilized.

14. Measuring Method of Inductance

(1) Residual elements and stray elements of test fixture can be described by F-parameter shown in following.



(2) The impedance of chip coil Z_x and measured value Z_m can be described by input/output current/voltage.

$$Z_m = \frac{V_1}{I_1} \quad , \quad Z_x = \frac{V_2}{I_2}$$

(3) Thus, the relation between Z_x and Z_m is following:

$$Z_x = \alpha \frac{Z_m - \beta}{1 - Z_m \Gamma} \quad \text{where, } \alpha = D / A = 1$$

$$\beta = B / D = Z_{sm} - (1 - Y_{om} Z_{sm}) Z_{ss}$$

$$\Gamma = C / A = Y_{om}$$

(4) L_x and Q_x shall be calculated with the following equation.

$$L_x = \frac{\text{Im}(Z_x)}{2\pi f} \quad , \quad Q_x = \frac{\text{Im}(Z_x)}{\text{Re}(Z_x)}$$

L_x : Inductance of chip coil
 Q_x : Q of chip coil
 f : Measuring frequency